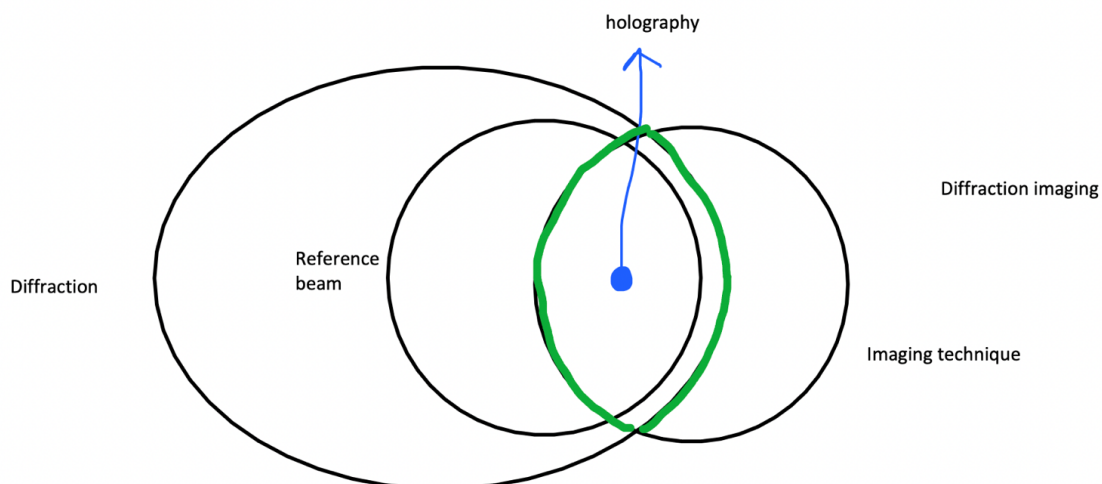


## New subclass relationships Draft 7

These class-pairs should be interpreted as [parent class, child class].

The ones highlighted in green are the relationships that are likely correct. The ones in yellow require further expert validation. The ones in red are likely incorrect, resulting either from errors in the original PaNET or from overly strong logical assertions where equivalence axioms were inappropriately used instead of subclass axioms.

1. ['defined by purpose', 'magnetism\_technique']
2. ['neutron\_technique', 'neutron time of flight\_technique']
3. ['scattering\_technique', 'diffuse scattering\_technique']
4. ['spatial map\_technique', 'microscopy\_technique']
5. ['photoemission spectroscopy\_technique', 'angle resolved photoemission spectroscopy\_technique']
6. ['fluorescence imaging\_technique', 'fluorescence tomography\_technique']
7. ['x-ray diffraction\_technique', 'x-ray powder diffraction\_technique']
8. ['x-ray diffraction\_technique', 'x-ray single crystal diffraction\_technique']
9. ['x-ray photoelectron spectroscopy\_technique', 'hard x-ray photoelectron spectroscopy\_technique']
10. ['photoemission spectroscopy\_technique', 'high resolution photoelectron spectroscopy\_technique']
11. ['electron spectroscopy\_technique', 'high resolution photoelectron spectroscopy\_technique']
12. ['diffraction imaging\_technique', 'holography\_technique']
  - <holography> is a subclass of <reference beam>, which is a subclass of <diffraction>.
  - <holography> is also a subclass of <imaging\_technique>.
  - <diffraction imaging> is equivalent to <diffraction> and <imaging\_technique>.

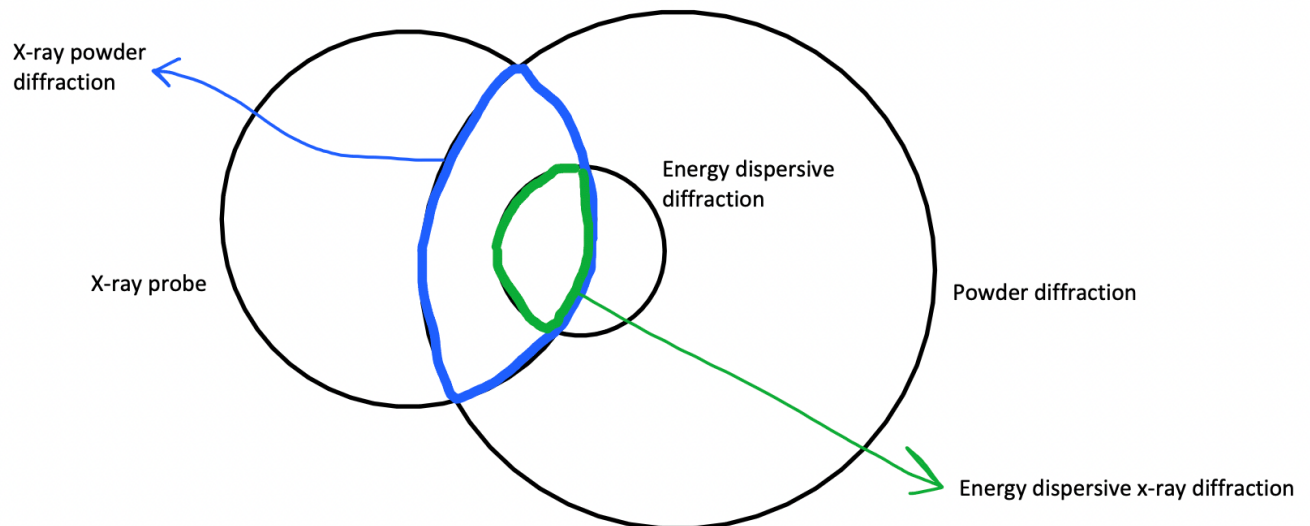


- Suggestion: Revert <diffraction imaging> back to a subclass of <diffraction> and <imaging\_technique>.

13. ['infrared microscopy\_technique', 'infrared microspectroscopy\_technique']
14. ['obtain high resolution spatial map\_technique', 'fluorescence microscopy\_technique']
15. ['reflectometry\_technique', 'polarised reflectivity\_technique']
16. ['neutron scattering\_technique', 'quasielastic neutron spin echo scattering\_technique']
17. ['absorption contrast imaging\_technique', 'scanning transmission microscopy\_technique']
18. ['scanning probe microscopy\_technique', 'scanning transmission microscopy\_technique']
19. ['neutron scattering\_technique', 'spin echo resolved grazing incidence scattering\_technique']
20. ['neutron scattering\_technique', 'spin echo small angle scattering\_technique']
21. ['magnetic circular dichroism\_technique', 'x-ray magnetic circular dichroism\_technique']
22. ['x-ray absorption\_technique', 'x-ray magnetic circular dichroism\_technique']
23. ['circular dichroism\_technique', 'magnetic circular dichroism\_technique']
24. ['circular dichroism\_technique', 'natural circular dichroism\_technique']
25. ['obtain high resolution spatial map\_technique', 'electron microscopy\_technique']
26. ['photoelectron emission\_technique', 'photoemission electron microscopy\_technique']
27. ['obtain high resolution spatial map\_technique', 'scanning probe microscopy\_technique']
28. ['reflectometry\_technique', 'x-ray reflectivity\_technique']
29. ['absorption contrast imaging\_technique', 'absorption tomography\_technique']
30. ['phase contrast imaging\_technique', 'propagation phase contrast tomography\_technique']
31. ['microtomography\_technique', 'nanotomography\_technique']
32. ['phase contrast imaging\_technique', 'absorption and phase contrast nanotomography\_technique']
33. ['absorption microtomography\_technique', 'absorption and phase contrast nanotomography\_technique']

34. ['x-ray powder diffraction\_technique', 'energy dispersive x-ray diffraction\_technique']

- <energy dispersive x-ray diffraction> ⇔ <energy dispersive diffraction> and <x-ray probe>
- <energy dispersive diffraction> is subclass of <powder diffraction>
- <x-ray powder diffraction> ⇔ <x-ray probe> and <powder diffraction>
- Suggestion: Revert <x-ray powder diffraction> back to a subclass of <x-ray probe> and <powder diffraction>



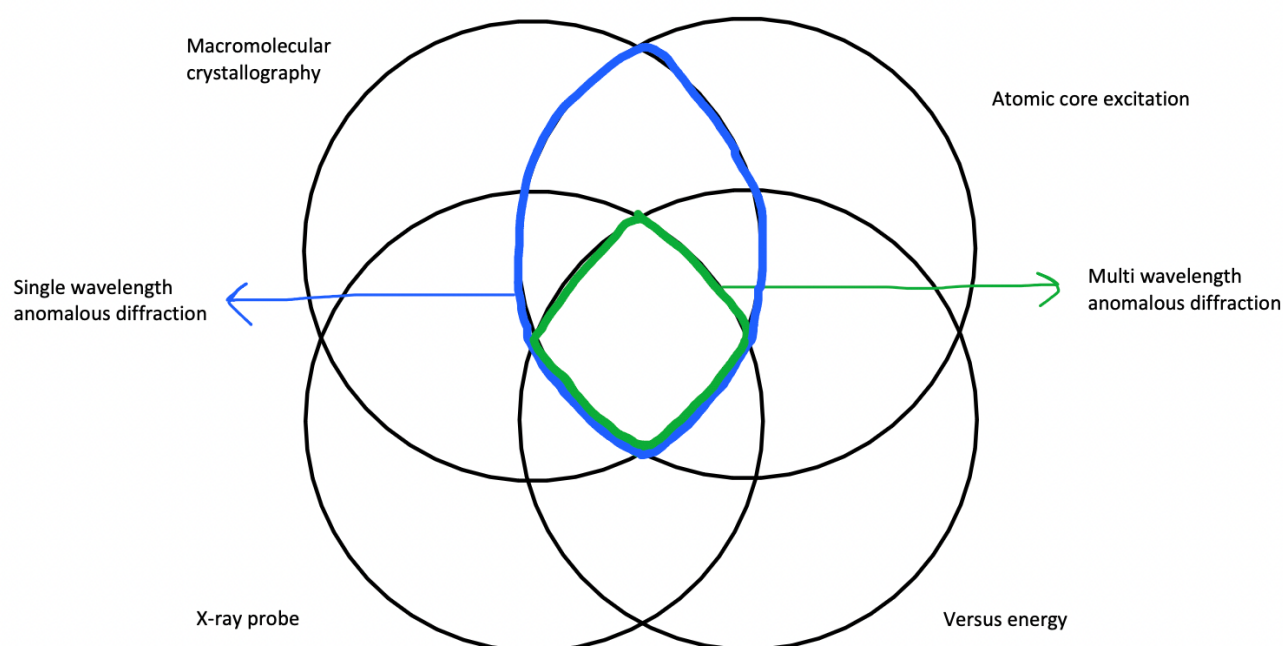
35. ['x-ray scattering\_technique', 'grazing incidence x-ray diffraction\_technique']

36. ['grazing incidence x-ray diffraction\_technique', 'grazing incidence small angle x-ray scattering\_technique']

37. ['x-ray single crystal diffraction\_technique', 'multi wavelength anomalous diffraction\_technique']

38. ['single wavelength anomalous diffraction\_technique', 'multi wavelength anomalous diffraction\_technique']

- <Multi wavelength anomalous diffraction> ⇔ <macromolecular crystallography> and <versus energy> and <atomic core excitation> and <x-ray probe>
- <Single wavelength anomalous diffraction> ⇔ <macromolecular crystallography> and <atomic core excitation>



- Suggestion: Revert <Single wavelength anomalous diffraction> back to a subclass of <macromolecular crystallography> and <atomic core excitation>

39. ['photoelectron emission\_technique', 'photoelectron diffraction\_technique']

40. ['serial synchrotron crystallography\_technique', 'serial femtosecond crystallography\_technique']

41. ['x-ray diffraction\_technique', 'surface x-ray diffraction\_technique']

42. ['x-ray diffraction\_technique', 'x-ray standing wave\_technique']

43. ['x-ray absorption\_technique', 'x-ray standing wave\_technique']

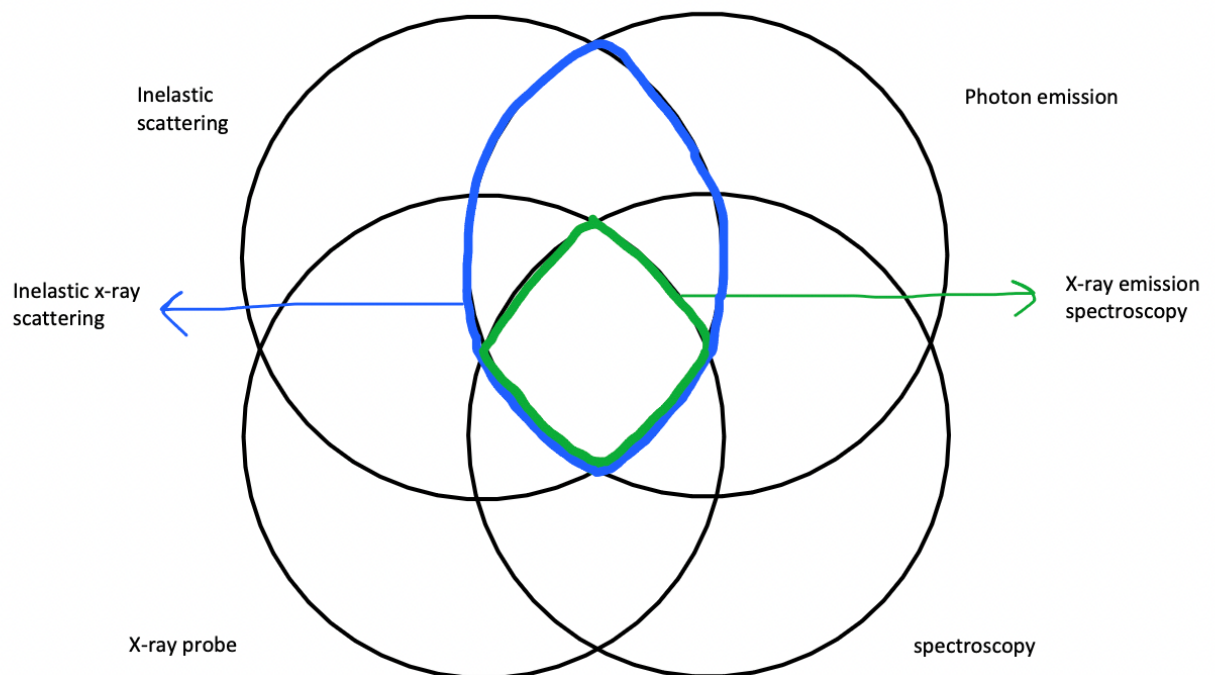
- <x-ray standing wave> is subclass of <absorption technique>
- <x-ray standing wave> is subclass of <x-ray probe>
- <x-ray absorption> ⇔ <absorption technique> and <x-ray probe>
- Already suggested to remove <absorption technique> as a parent class of <x-ray standing wave>. Can submit as an issue to PaNET group in the future.

44. ['diffraction imaging\_technique', 'coherent diffraction imaging\_technique']

45. ['infrared microspectroscopy\_technique', 'infrared nanospectroscopy imaging\_technique']

46. ['UV circular dichroism\_technique', 'UV circular dichroism imaging\_technique']
47. ['obtain high resolution spatial map\_technique', 'infrared microscopy\_technique']
48. ['obtain high resolution spatial map\_technique', 'optical microscopy\_technique']
49. ['obtain high resolution spatial map\_technique', 'x-ray microscopy\_technique']
50. ['x-ray imaging\_technique', 'x-ray microscopy\_technique']
51. ['x-ray scattering\_technique', 'inelastic x-ray scattering\_technique']
52. ['raman spectroscopy\_technique', 'inelastic x-ray scattering\_technique']
53. ['resonant x-ray scattering\_technique', 'resonant inelastic x-ray scattering\_technique']
54. ['x-ray scattering\_technique', 'small angle x-ray scattering\_technique']
55. ['x-ray diffraction\_technique', 'wide angle x-ray scattering\_technique']
56. ['inelastic x-ray scattering\_technique', 'x-ray emission spectroscopy\_technique']

- <x-ray emission spectroscopy> ⇔ <inelastic scattering> and <x-ray probe> and <photon emission> and <spectroscopy>
- <inelastic x-ray scattering> ⇔ <x-ray probe > and <inelastic scattering>

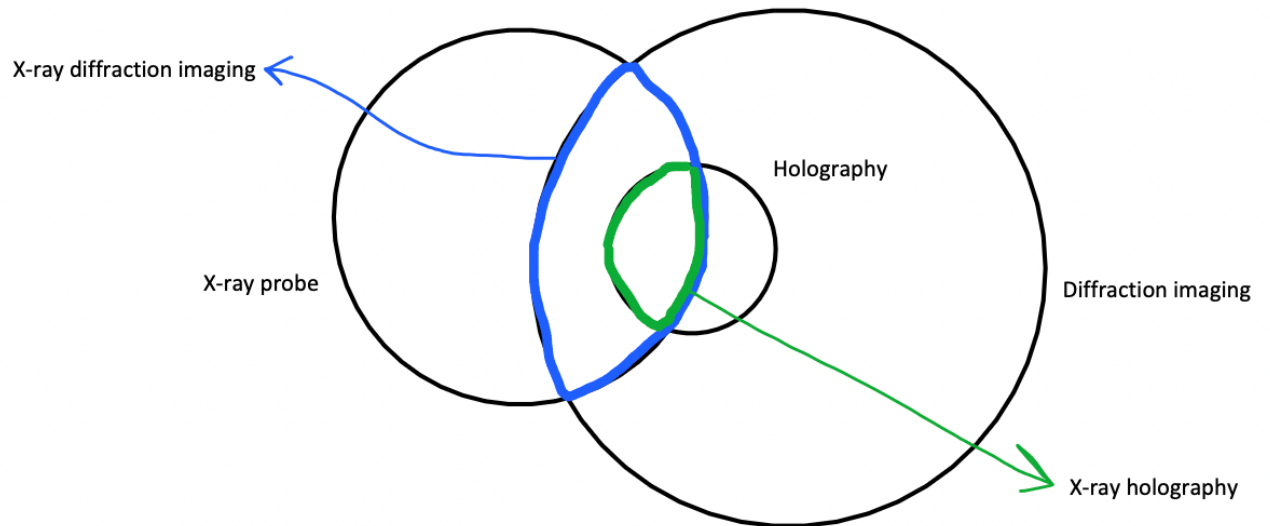


- Suggestion: Revert <inelastic x-ray scattering> back to a subclass of <x-ray probe > and <inelastic scattering>

- 57.['photoelectron emission\_technique', 'photoelectron spectroscopy\_technique']
- 58.['x-ray photoelectron emission\_technique', 'x-ray photoelectron spectroscopy\_technique']
- 59.['x-ray diffraction\_technique', 'x-ray photon correlation spectroscopy\_technique']
- 60.['microscopy\_technique', 'microtomography\_technique']
- 61.['x-ray imaging\_technique', 'x-ray tomography\_technique']
- 62.['x-ray microscopy\_technique', 'x-ray microtomography\_technique']
- 63.['x-ray tomography\_technique', 'x-ray microtomography\_technique']
- 64.['absorption tomography\_technique', 'absorption microtomography\_technique']
- 65.['microtomography\_technique', 'propagation phase contrast microtomography\_technique']
- 66.['microtomography\_technique', 'ultrafast microtomography\_technique']
- 67.['x-ray scattering\_technique', 'x-ray diffraction\_technique']
- 68.['neutron scattering\_technique', 'neutron diffraction\_technique']
- 69.['x-ray absorption\_technique', 'scanning transmission x-ray microscopy\_technique']
- 70.['x-ray scanning microscopy\_technique', 'scanning transmission x-ray microscopy\_technique']
- 71.['x-ray photoelectron emission\_technique', 'XMCD total electron yield\_technique']
- 72.['neutron scattering\_technique', 'ultra small angle neutron scattering\_technique']
- 73.['small angle x-ray scattering\_technique', 'ultra small angle x-ray scattering\_technique']
- 74.['polarised reflectivity\_technique', 'polarized neutron reflectometry\_technique']
- 75.['neutron scattering\_technique', 'inelastic neutron spectroscopy\_technique']
- 76.['thermal neutron spectroscopy\_technique', 'cold neutron spectroscopy\_technique']
- 77.['absorption contrast imaging\_technique', 'neutron transmission radiography\_technique']
- 78.['microscopy\_technique', 'high-resolution neutron imaging\_technique']
- 79.['obtain high resolution spatial map\_technique', 'THz near field microscopy\_technique']
- 80.['x-ray absorption\_technique', 'x-ray magnetic linear dichroism\_technique']
- 81.['phase contrast imaging\_technique', 'x-ray refraction imaging\_technique']
- 82.['x-ray imaging\_technique', 'x-ray refraction imaging\_technique']
- 83.['x-ray tomography\_technique', 'x-ray refraction tomography\_technique']
- 84.['x-ray refraction imaging\_technique', 'x-ray refraction tomography\_technique']

85. ['x-ray diffraction imaging\_technique', 'x-ray holography\_technique']

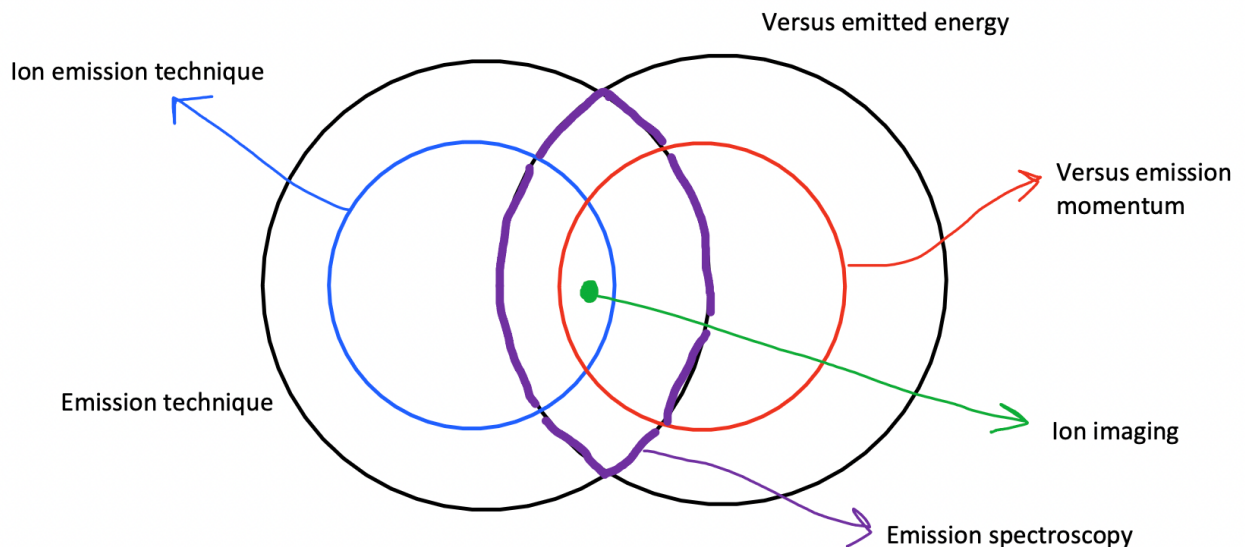
- <x-ray holography>  $\Leftrightarrow$  <x-ray probe> and <holography>
- <holography> is subclass of <diffraction imaging>
- <x-ray diffraction imaging>  $\Leftrightarrow$  <x-ray probe> and <diffraction imaging>



- Suggestion: Revert <x-ray diffraction imaging> back to a subclass of <x-ray probe> and <diffraction imaging>

86. ['emission spectroscopy\_technique', 'ion imaging\_technique']

- <ion imaging> ⇔ <ion emission technique> and <photon technique> and <versus emission momentum>
  - <ion emission technique> is subclass of <emission\_technique>
  - <versus emission momentum> is subclass of <versus emitted energy>
- <emission spectroscopy> ⇔ <emission\_technique> and <versus emitted energy>



- <photon technique> was not included in the above diagram to make it less cluttered, but the logic still holds
- Suggestion: Revert <emission spectroscopy> back to a subclass of <emission\_technique> and <versus emitted energy>

87. ['small angle x-ray scattering\_technique', 'anomalous small angle x-ray scattering\_technique']

88. ['x-ray diffraction\_technique', 'anomalous small angle x-ray scattering\_technique']

89. ['resonant elastic x-ray scattering\_technique', 'anomalous small angle x-ray scattering\_technique']

90. ['neutron time of flight\_technique', 'time of flight small angle neutron scattering\_technique']

91. ['ultra small angle neutron scattering\_technique', 'very small angle neutron scattering\_technique']

92. ['small angle x-ray scattering\_technique', 'diffuse small angle x-ray scattering\_technique']

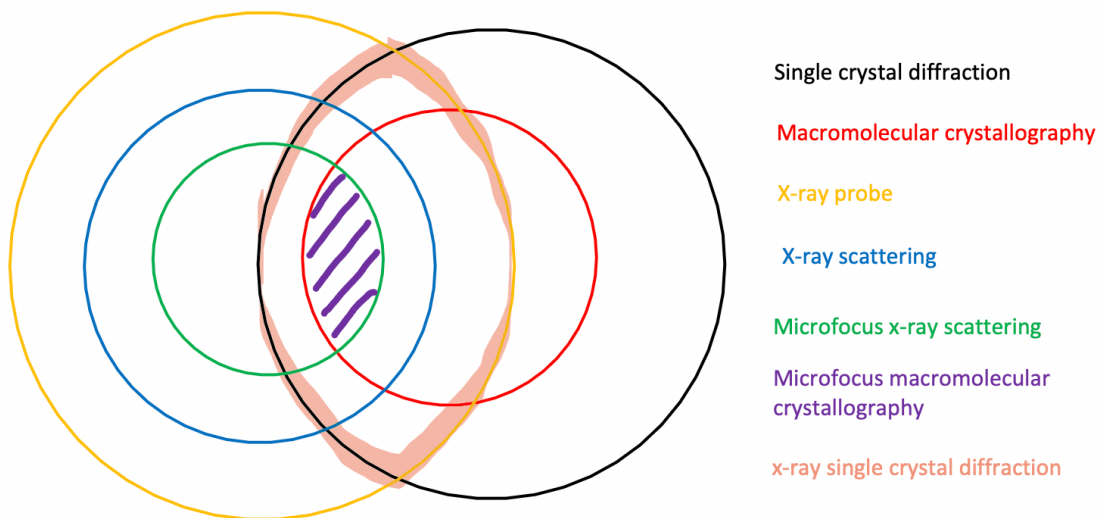
93. ['inelastic small angle scattering\_technique', 'inelastic x-ray small angle scattering\_technique']



- 94. ['x-ray diffraction\_technique', 'soft x-ray diffraction\_technique']
- 95. ['x-ray photoelectron emission\_technique', 'x-ray photoelectron diffraction\_technique']
- 96. ['x-ray microtomography\_technique', 'micro small angle x-ray scattering tomography\_technique']
- 97. ['fluorescence imaging\_technique', 'scanning x-ray fluorescence\_technique']
- 98. ['soft x-ray probe\_technique', 'soft x-ray imaging\_technique']
- 99. ['x-ray diffraction\_technique', 'x-ray diffraction imaging\_technique']
- 100. ['x-ray imaging\_technique', 'x-ray diffraction imaging\_technique']
- 101. ['scanning photoelectron microscopy\_technique', 'scanning angle resolved photoemission spectromicroscopy\_technique']
- 102. ['x-ray microscopy\_technique', 'x-ray photoemission electron microscopy\_technique']
- 103. ['x-ray photoelectron emission\_technique', 'x-ray photoemission electron microscopy\_technique']
- 104. ['neutron scattering\_technique', 'elastic neutron scattering spectroscopy\_technique']
- 105. ['x-ray absorption\_technique', 'x-ray linear dichroism\_technique']
- 106. ['x-ray linear dichroism\_technique', 'x-ray natural linear dichroism\_technique']
- 107. ['x-ray single crystal diffraction\_technique', 'long wavelength crystallography\_technique']

108. ['x-ray single crystal diffraction\_technique', 'microfocus macromolecular crystallography\_technique']

- <microfocus macromolecular crystallography> ⇔ <macromolecular crystallography> and <microfocus x-ray scattering>
  - <macromolecular crystallography> is subclass of <single crystal diffraction>
  - <microfocus x-ray scattering> ⇔ <microfocussed probe> and <x-ray scattering>
    - <x-ray scattering> ⇔ <scattering> and <x-ray probe>
- <x-ray single crystal diffraction> ⇔ <x-ray probe> and <single crystal diffraction>



- I tried to make the diagram as simple as possible, but basically, <microfocus macromolecular crystallography> is a subclass of both <x-ray probe> and <single crystal diffraction>, which makes it a subclass of <x-ray single crystal diffraction>
  - <microfocus macromolecular crystallography> ⊆ <macromolecular crystallography> ⊆ <single crystal diffraction>
  - <microfocus macromolecular crystallography> ⊆ <microfocus x-ray scattering> ⊆ <x-ray scattering> ⊆ <x-ray probe>
- Suggestion: Revert <x-ray single crystal diffraction> back to a subclass of <x-ray probe> and <single crystal diffraction>

109. ['microfocus macromolecular crystallography\_technique', 'nanofocus macromolecular crystallography\_technique']

110. ['time resolved serial synchrotron crystallography\_technique', 'time resolved serial femtosecond crystallography\_technique']

111. ['grazing incidence x-ray diffraction\_technique', 'grazing incidence wide angle scattering\_technique']

112. ['obtain high resolution spatial map\_technique', 'atomic force microscopy\_technique']

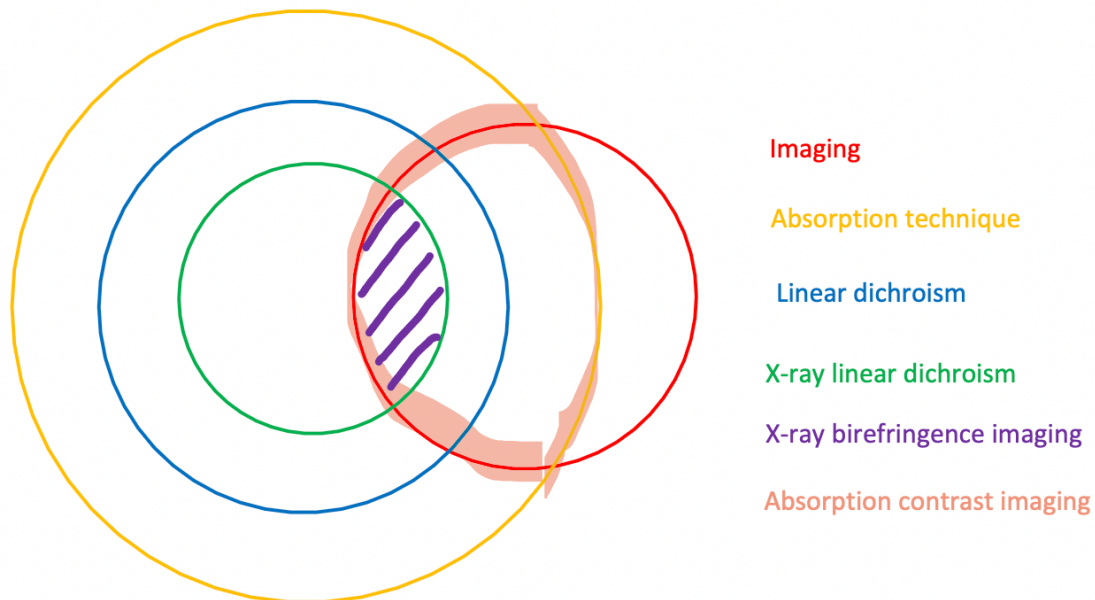
113. ['infrared microspectroscopy\_technique', 'atomic force microscope  
infrared spectroscopy\_technique']

114. ['microfocus spectroscopy\_technique', 'microfocus x-ray absorption  
spectroscopy\_technique']

115. ['x-ray single crystal diffraction\_technique', 'borrmann effect\_technique']

116. ['absorption contrast imaging\_technique', 'x-ray birefringence imaging  
technique']

- <x-ray birefringence imaging>  $\Leftrightarrow$  <birefringence technique> and <x-ray linear dichroism> and <imaging>
  - <x-ray linear dichroism>  $\Leftrightarrow$  <x-ray probe> and <linear dichroism>
    - <linear dichroism>  $\Leftrightarrow$  <absorption technique> and <versus photon linear polarization> and <dichroism>
- <absorption contrast imaging>  $\Leftrightarrow$  <absorption technique> and <imaging>



- Again, this is quite complicated, so I trimmed down the diagram to make it more understandable.
- <x-ray birefringence imaging> is a subclass of <absorption technique> and <imaging>, which makes it a subclass of <absorption contrast imaging>
  - <x-ray birefringence imaging>  $\subseteq$  <x-ray linear dichroism>  $\subseteq$  <linear dichroism>  $\subseteq$  <absorption technique>
  - <x-ray birefringence imaging>  $\subseteq$  <imaging>
- Suggestion: Revert <absorption contrast imaging> back to a subclass of <absorption technique> and <imaging>

117. ['x-ray refraction imaging\_technique', 'x-ray birefringence imaging  
technique']